Microstructure Formation in Sn-Cu-Ni Solder Alloys*

M. Felberbaum, T. Ventura, M. Rappaz, and A.K. Dahle

A systematic study of the solidification mechanisms of binary Sn-Cu and ternary Sn-Cu-Ni alloys has been carried out. It is found that Sn-Cu is a weakly-irregular eutectic system with Cu₆Sn₅ as the leading phase. Interestingly, two different eutectic morphologies (coarse and fine) are found to grow simultaneously during eutectic solidification. When the growth rate or composition are changed, the eutectic interface breaks down into a cellular eutectic with the fine eutectic in the centre of the cells and the coarse one at the cell boundaries. The mechanisms responsible for these phenomena are discussed in conjunction with the beneficial effect of Ni additions to the Sn-Cu solder.

INTRODUCTION

For the past 50 years, eutectic and near-eutectic tin-lead (Sn-Pb) solders have provided an effective solution for joining metallic surfaces in the electronics industry. The low cost and low melting point of the Pb-Sn eutectic (T₁ = 456 K) made such alloys particularly suitable for soldering thermally sensitive electronic components. However, due to its high toxicity, lead has been banned from the European Union (EU) market and new electronic equipment must now contain less than 1,000 ppm Pb (EU Directive 2002/95). For the past decade, this has stimulated the search for an optimum lead-free replacement solder.

Because of the relatively low melting temperature of tin (Tₘ = 505 K), Sn-rich alloys are good candidates for lead-free solders. A hypoeutectic alloy with a short freezing range is generally chosen, because (i) a hypereutectic composition is detrimental for soldering properties since the primary intermetallic phase can form short circuits and (ii) a reduced solidification interval decreases the chance of defects formation such as hot tears. In that prospect, copper (Cu) is often used as an alloying element and the composition Sn-0.7wt.%Cu is of particular interest. Not only having good soldering properties and cost advantages compared to Ag-containing solder alloys, this alloy exhibits soldering properties that can be significantly improved by small additions of nickel (Ni). Although Sn-Cu-Ni alloys are already commercially in use, their solidification mechanisms remain unclear and the influence of Ni on the binary Sn-0.7Cu alloy also needs to be further understood (unless otherwise specified, all compositions are given in wt.%).

Using Bridgman solidification experiments, we have recently investigated the solidification mechanisms of Sn-rich Sn-Cu-Ni alloys and identified several mechanisms responsible for the beneficial effect of Ni in the Sn-0.7Cu solder. This paper gives an overview on the progress in understanding microstructure formation in this new solder.

BINARY SN-CU ALLOYS

The main results for the binary Sn-Cu alloys are summarized in Figure 1, which shows the influence of growth velocity and Cu content on the microstructure. For relatively high growth velocities and Cu contents less than 0.9 wt.% a microstructure consisting of primary β-Sn cells or dendrites surrounded by eutectic (β-Sn + intermetallic Cu₆Sn₅) was obtained (see Figure 1a). On the other hand, a fully eutectic microstructure was obtained in the cases of: i) low growth velocities, independent of Cu content (see Figure 1b) and ii) a fixed composition of Sn-0.9Cu, independent of growth velocity (see Figure 1c). Thus, a transition from off-eutectic to fully eutectic microstructure is observed to occur in
the hypoeutectic alloy when the pulling speed is increased. This is a classical transition in solidification science and is caused by the competition in growth kinetics between β-tin dendrites (or cells) and the eutectic.5

Focusing now on the eutectic morphology, Figure 2a shows a longitudinal cross-section of a Sn-0.7Cu alloy grown at 2 µm/s. Although the eutectic interface seems planar at this magnification, it is not strictly isothermal at higher magnification, with Cu6Sn5 intermetallic phase is only slightly branched. Returning to the faceted Cu6Sn5 phase, the faceted Cu6Sn5 intermetallic phase, which is a typical characteristic of a γ (~0.12 K), tions on the order of 50 m/s. The

The hypoeutectic alloy 0.7Cu-0.03Ni grown at 10 µm/s. The eutectic interface contains perturbations on the order of 50 µm (~0.12 K), which is a typical characteristic of a weakly irregular eutectic, i.e., where the faceted Cu6Sn5 intermetallic phase is only slightly branched. Returning to the phase diagram shown in Figure 1, this suggests that the coupled zone is not much biased towards the faceted Cu6Sn5 phase. Hence, for any growth velocity, no primary β-Sn dendrites should form at the eutectic composition. While there is some ambiguity regarding the eutectic composition in the Sn-Cu system in the literature, our work clearly shows that Sn-0.9Cu is the eutectic composition since a fully eutectic microstructure was found for all growth velocities only at this composition. These results are also in good agreement with the work by Machida et al. on near-eutectic Sn-Cu alloys5 (although a higher thermal gradient was used in their case \(G = 4.7 \text{ K/mm}\)). To complete the coupled zone in Figure 1, the dashed line separating the fully eutectic microstructure from the primary Cu6Sn5 + eutectic structure has been drawn based on the data of Machida et al.7

Another interesting eutectic microstructure transition can be observed by comparing the micrographs in Figure 1b and Figure 1c: a fully eutectic structure was obtained at low growth velocities, whereas cellular eutectic structures were produced as the growth rate was increased. This morphology change can be explained by the segregation of trace impurities, particularly Pb. Indeed, the destabilization velocity of a tin front (the eutectic front con-sists of 97% tin) due to Pb segregation theoretically occurs for the given solidification conditions between 10 and 20 µm/s, which coincides with the experimental results. These observations are further confirmed by casting experiments of ultrapure Sn-0.9Cu and Sn-0.9Cu-0.03Pb alloys. A very fine eutectic morphology was found in the Sn-0.9Cu alloy, whereas a cellular bimodal eutectic structure similar to the one shown in Figure 1c formed in the Sn-0.9Cu-0.03Pb alloy. This is similar to the observations by Kraft and Albright8 who found that when the growth rate is very high or the thermal gradient in the liquid at the growing interface is very low, a layer of constitutionally supercooled liquid formed by solute rejection induces a cellular rather than a planar interface of the Al-Al2Cu eutectic. On the other hand, trace level additions of Ag to ultrapure Sn-0.9Cu resulted in the formation of fine primary β-Sn dendrites, suggesting that Ag could be a potential grain refiner for Sn. However, a separate study refuted this theory and showed that Ag seems to simply stabilize the β-Sn phase field in the phase diagram without refining the microstructure.9

Focusing on Figure 1b, it can be observed that the eutectic morphology is not uniform and can be either fine or coarse. Two separate domains are clearly distinguished, one with a very fine fiber spacing (λ) and the other with a much coarser morphology. This is very unusual, especially in a specimen of constant composition and grown at steady-state. Even more surprising, both morphologies have been found to be stable for a range of growth velocities and with each morphology following the classical \(\lambda^2 = \nu = \text{constant}\) relationship. This bimodal eutectic structure was previously reported by Drevet et al.10,11 who showed that, for both morphologies, the Cu6Sn5 fibers grow with the basal plane of their hexagonal structure parallel to the eutectic front. Preliminary electron backscatter diffraction (EBSD) results suggest that the orientation of the Sn matrix plays a significant role in the eutectic morphology, but the mechanisms remain unclear.

THE EFFECT OF Ni

The effect of Ni additions was studied in the Sn-0.7Cu system for several reasons: (i) it would include the composition of the commercial solder SN100C,2 (ii) it is important to start with a hypoeutectic alloy (but close to the binary eutectic composition), since in electronics, the coarse primary Cu6Sn5 particles must be avoided as they can form bridges and short circuits during the wave soldering process, and (iii) comparisons with the binary sys-tem Sn-Cu can be made.

The results are summarized in Figure 3 where four separate regions (denoted I to IV) are differentiated. Regions I and IV correspond to off-eutectic regions where β-Sn dendrites (or cells) and primary Cu6Sn5 were observed, respectively. Clearly, no primary phase β-Sn was obtained for any Ni-containing alloy which shows that Ni appears to suppress the formation of β-Sn dendrites in favor of a eutectic microstructure (which is beneficial in

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**EXPERIMENTAL PROCEDURE**

The research was conducted in three steps: firstly, the solidification mechanisms in the binary Sn-Cu alloy were investigated; secondly, the effect of Ni was considered; and thirdly, an ultrapure Sn-0.9Cu alloy was cast in order to investigate the individual effects of common trace impurities present in commercial Sn-Cu alloys (typically Ag and Pb). Accordingly, three binary Sn-Cu alloys (Sn-0.5Cu, Sn-0.7Cu, and Sn-0.9Cu) were solidified in a classical Bridgman furnace (see Reference 4 for details). The samples were drawn at a given constant velocity \((v = 2, 5, 10, 20, 50, \text{or } 100 \text{ µm/s})\) in a 1D temperature gradient \((G)\) of about 2.5 K/mm. After about 60 mm of growth, the specimens were quenched into cold water to freeze the microstructure. Conventional grinding/polishing was performed to prepare samples for optical and electron microscopy (scanning electron microscopy and transmission electron microscopy) coupled with chemical analysis (energy dispersive spectroscopy). The same experimental procedure was then followed to investigate the effect of Ni in a Sn-0.7Cu-xNi alloy \((x = 0.03, 0.05, 0.08, \text{and } 0.1)\). Finally, an ultrapure Sn-0.9Cu alloy, contained in a conical cup of about 17 cm³, was solidified in air (typical cooling rate of 0.5 K/s). The effects of separate additions of elemental powders of Pb (300 ppm) and Ag (10 ppm) were studied.5
term of soldering). On the other hand, a eutectic microstructure was obtained in regions II and III, where intermixed coarse and fine eutectics and a cellular eutectic morphology were observed, respectively. This transition is similar to that observed in the Sn-Cu system (see microstructures (b) and (c) in Figure 1) and is due to segregation of trace elements, particularly Pb, ahead of the eutectic interface. The transition occurred at the same growth rate as in the binary Sn-Cu system and was not influenced by the Ni level. This was expected since Ni is known to be strongly segregated by Sn and highly soluble in Cu₆Sn₅ to form (Cu,Ni)₆Sn₅\(^{12}\).

Figure 3 shows that Ni has a strong influence on the microstructure of Sn-0.7Cu-xNi alloys. For example, for a growth rate of 10 μm/s, a transition from hypoeutectic (Figure 3a) → fully eutectic (Figure 3b) → hypereutectic microstructure (Figure 3c) is observed as the Ni content is increased. Again, this can be explained by the coupled zone concept. The dashed lines in the figure show the coupled zone for the ternary system and suggest that the coupled zone is strongly biased towards the faceted phase, i.e., much more than in the Sn-Cu binary system. Indeed, the eutectic interface becomes much more non-isothermal when Ni is added to binary Sn-Cu alloys\(^{4,5}\), suggesting a more faceted intermetallic phase (compare both microstructures in Figure 2). This is probably due to the influence of Ni on the solid-liquid interfacial energy, which could transform the weakly irregular Sn-Cu eutectic into a strongly irregular eutectic in the ternary alloys.

Interestingly, the Sn-0.7Cu-0.03Ni alloy was the only alloy that exhibited a fully eutectic morphology across the range of velocities investigated, indicating that the eutectic valley is located at, or near, this composition. The Sn-rich corner of the Sn-Cu-Ni phase diagram is still under discussion in the literature, and the composition found here appears quite low compared to the phase diagram given in Reference 13, but is in better agreement with the phase diagram given in Reference 12, where there is a eutectic valley between the β-Sn phase field and the (Cu,Ni)₆Sn₅ phase field at about 200 ppm Ni. Additionally, fluidity studies have shown that the maximum fluidity length is achieved with an alloy containing 500 ppm Ni\(^{14}\). Since alloys with a long fluidity length are related to short freezing range alloys, i.e., fully eutectic alloys, this result suggests that the eutectic composition is close to Sn-0.7Cu-0.05Ni. The ternary exact eutectic composition is therefore still debated.

As for the binary eutectic alloy, a transition from a fully eutectic (Figure 3b) to a cellular eutectic microstructure (Figure 3c) occurs in all Ni-containing...
alloys at \( v \approx 20 \mu \text{m/s} \). Once again this transition can be attributed to the segregation of ppm levels of Pb and is not influenced by the Ni level since this element is segregated from the \( \beta \)-Sn into the \((\text{Cu},\text{Ni})_6\text{Sn}_5\) intermetallic. What remains unclear, however, is the coexistence of two scales of the eutectic microstructure, obeying the classical relationship \( \lambda^2 \nu = \text{constant} \) if an average value of \( \lambda \) is assumed. In Figure 3b for instance, regions with small \( \lambda \) are separated by regions where the eutectic microstructure is much coarser. This is even more pronounced at high Ni content (see Figure 3d), suggesting that Ni strongly influences the interfacial energies of the eutectic phases. However, as opposed to the binary alloy, it is very unlikely here that the orientation of the \( \beta \)-Sn matrix is responsible for this change in eutectic morphology. To clarify this question, a TEM study was performed on both fine and coarse intermetallics in Sn-0.9Cu and Sn-0.7Cu-0.08Ni alloys.\(^{15}\) Both fine and coarse intermetallics in the binary alloy were identified as monoclinic \( \eta' - \text{Cu}_6\text{Sn}_5 \), as predicted by Shim et al.\(^{16}\). However, the ternary alloy is different: the fine intermetallic was identified as monoclinic \( \eta' - \text{Cu}_6\text{Sn}_5 \) with a Ni content of about 8 at.\%, but a new and unknown cubic structure was found in the coarse intermetallic.\(^{15}\) Moreover, the center of the coarse intermetallic contains more Ni (about 12 at.\%), whereas the outer edges are Ni-free. In both cases, no trace of Ni was found in the \( \beta \)-Sn matrix. This suggests that the coarse intermetallic is metastable while the fine eutectic is the stable phase in Ni-containing Sn-Cu solder. It is thought that coarsening experiments might bring some further insight into these questions.

**CONCLUSIONS**

This study focused on the microstructure formation in near-eutectic Sn-Cu and Sn-0.7Cu-xNi alloys. For both the binary and ternary systems, a transition from fully eutectic to off-eutectic microstructure with increasing growth velocity was explained by the coupled zone concept. The eutectic was identified as weakly irregular in the binary system and strongly irregular in the ternary alloys, probably due to the influence of Ni on the interfacial energy of the eutectic phases. Consequently, the coupled zone is thought to be slightly and strongly biased toward the faceted intermetallic phase in the binary and ternary system, respectively. In both systems, a transition from fully eutectic to cellular eutectic structures was observed as the growth velocity was increased. It was found that this change in morphology is due to the segregation of impurity elements, particularly Pb, and is not affected by the Ni content, as the latter element is strongly soluble in the intermetallic phase. In terms of solderability, it is thought that Ni additions to Sn-0.7Cu shift the hypoeutectic binary composition to a near ternary eutectic, which improves the fluidity and reduces the freezing range. The influence of Ni on the interfacial energy of the different phases is also probably beneficial in terms of wettability (as observed commercially) and further studies are required to confirm this suggestion.

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**References**


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